

Notice of References Cited	Application/Control No. 09/998,459	Applicant(s)/Patent Under Reexamination CHOW ET AL.	
	Examiner Thuy Pardo	Art Unit 2165	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,625,616	09-2003	Dragon et al.	707/104.1
	B	US-6,871,110	03-2005	Yen et al.	700/100
	C	US-2002/0055886	05-2002	Hinckley, Paul F.	705/26
	D	US-2002/0138316	09-2002	Katz et al.	705/7
	E	US-2002/0156706	10-2002	Naish et al.	705/28
	F	US-2002/0004761	01-2002	Sekitani, Hiroyuki	705/26
	G	US-2002/0103721	08-2002	Wiesehuegel et al.	705/27
	H	US-2002/0128859	09-2002	Perkowski, Thomas J.	705/1
	I	US-2002/0165701	11-2002	Lichtenberg et al.	703/7
	J	US-2002/0188528	12-2002	Adelman et al.	705/28
	K	US-2003/0115115	06-2003	Ouchi, Norman Ken	705/27
	L	US-2003/0093380	05-2003	Esmailzadeh, Arash	705/50
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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